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REMARKS

Claims 23-64 are pending in this application. Claims 23 and 24 are

independent. Claims 47-64 have been added.

Added claims 47-57 correspond to claims 25 and 27-36, respectively,

but dependent on claim 24.

Added claim 58 corresponds to claim 46, but dependent on new claim

50.

Added claims 59-61 correspond to claims 40, 42, and 43, respectively,

but dependent on claim 38.

Added claims 62-64 correspond to claims 40, 42, and 43, respectively,

but dependent on claim 39.

It is noted that claims 23, 24, and 39 have been amended to replace

the phrase "consisting of" with the word "comprising", in order to be

consistent with the claim form existing in claims 37 and 38.

Allowable Subject Matter

Applicant thanks the Examiner for indicating that claims 26, 27, 28,

and 42 contain allowable subject matter.

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Drawings

The drawings have been objected to for not showing the feature of

claim 42 of a means for variation of the convergence of a bundle of rays. It is

noted that the subject matter of claim 42 is disclosed in the specification at

page 20, lines 16-23, which states that, "The convergence of the ray bundles

directed to the objective 32 and thereby the position of the auxiliary focus

71 relative to the measuring volume 70 can be varied by changing the

distances between the free end of the fiber 80 and the achromatic lens 31."

In other words, according to the specification, the relative focus position 71

is varied by moving the achromatic lens 31. In order to make this feature

explicit, the specification has been amended to state that changing the

distances between the free end of the fiber 80 and the achromatic lens 31 is

by lens mover portion 85 (i.e., the portion of the lens for carrying out

movement). Figure 6 has been revised to show a lens mover portion 85.

The revised Fig. 6 is submitted herewith as a drawing replacement sheet. It

is respectfully requested that the objection be withdrawn.

Claim Objection

Claim 42 has been objected to due to the phrase "those bundle of

rays". Accordingly, claim 42 has been amended. It is respectfully requested

that the objection be withdrawn.

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Claim Rejection - 35 USC 112

Claims 25-28, and 31 have been rejected under 35 U.S.C. 112, second

paragraph, as being indefinite. Accordingly, the claims have been amended

to render them definite. It is respectfully requested that the rejection be

withdrawn.

Claim Rejection - 35 U.S.C. 103

Claims 23, 25, 29-37, 39-41, 43, 44, and 46 have been rejected under

35 U.S.C. 103(a) as being unpatentable over U.S. Patent No. 6,181,474

(Ouderkirk et al.) in view of WO 98/44375 (Scherübl et al.) and WO

95/00871 (Picard). Applicant respectfully traverses this rejection.

Priority for the present application has been claimed based on a

provisional application filed in the U.S. Patent Office, US 60/113,478, for

which an English language translation had also been filed on March 3, 1999

(a copy is attached hereto). US 60/113,478 was filed on December 21, 1998.

The Ouderkirk reference has a filing date of March 22, 1999.

Because the date of the priority document 60/113,478 pre-dates the

filing date of the Ouderkirk reference, Applicant submits that the rejection

should be withdrawn.

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Accordingly, Applicant respectfully requests that the rejection be

withdrawn.

Claim Rejection - 35 U.S.C. 103

Claims 24, 38, and 45 have been rejected under 35 U.S.C. 103(a) as

being unpatentable over WO 98/44375 (Scherübl et al., "Scherübl") in view

of WO 95/00871 (Picard). Applicant respectfully traverses this rejection.

Summary of the Present Claimed Subject Matter

The present invention, in a preferred embodiment, is directed to a

method of using a confocal microscope, for example, for reliable

identification of an entity arranged on a sheet-support. The present confocal

microscope (e.g., Fig. 2) includes a conventional confocal radiation and

detection unit comprising, among other things, a radiation source (10) and

detector (20). Radiation from the radiation source is collimated by an optic

(33) and focused by an objective (32) on a substrate (60) to be examined. A

separate radiation source (11) is used for generation of an auxiliary focus

(71). Light from the separate radiation source is converged by an optic (31).

The auxiliary focus is made on the interface (62) between the substrate (60)

and the support (61). The reflected radiation at the interface (62) is focused

on the confocal arranged diaphragm (51) by means of the objective (32) and

optic (31) and detected by detector (21). Preferably, the auxiliary focus is

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positioned on the interface and the measuring volume is generated in a

desired distance from the auxiliary focus within the substrate.

A purpose of the auxiliary focus is to determine the position of the

interface and, in particular, to enable the detection of the distance between

the interface and the optic generating the auxiliary focus. The auxiliary

focus and measuring volume have a defined position to each other that is

adjustable by the user. Thus, it is possible to track the position of the

measuring volume relative to the interface by tracking the position of the

auxiliary focus. Then, the measuring volume may be guided in a defined

plane with selectable distance from the interface. (Paragraph bridging pages

3-4).

The invention of claim 24 sets the relative positions of the measuring

volume and the auxiliary focus. The claimed invention comprises, among

other things, a separate collimation of the radiation generated by a first

radiation source and of the radiation generated by a second radiation

source. Light rays are guided separately and collimated by separate optical

elements. By setting the relative positions of the measuring volume and

auxiliary focus, the present invention is capable of quantitatively

determining the spectral composition of light emitted from an entity.

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The present invention is particular suited for confocal detection of a

wide palette of optical parameters, e.g., spectral information such as

fluorescence intensity, fluorescence lifespan, Raman scattering.

<u>Scherübl</u>

Scherübl discloses an autofocus method for a confocal microscope.

The autofocus method can also be adopted for detecting deviations between

a first vertical profile and a second vertical profile, preferably to detect

defects in semiconductor structures. The confocal microscope includes a

means to produce a first wavelength selective division of the illuminating

light and means to produce a second wavelength selective division of light

detected from an object.

The confocal microscope operates by optically coding vertical height

information of an object as a color representation. Using selective division of

wavelength, illumination light of different wavelengths is focused in different

object planes. Light of different wavelengths is emitted by the object and

captured by different detector elements. The confocal microscope thus

obtains a vertical histogram, i.e., vertical distribution over a specific object

area. Height information is thereby transformed into a spectral intensity

distribution.

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Differences over Scherübl and Picard

The present invention, unlike Scherübl, ensures that the confocal

measuring volume is maintained in a desired plane/position within the

object. In the present invention, the relative positions of the measuring and

the auxiliary focus are set independently of wavelength. Thus, the present

invention is capable of quantitatively determining the spectral composition

of light emitted by the object. By quantitatively determining the spectral

composition of light emitted, the present invention can identify entities such

as molecules, polymers, cells, bacteria, viruses, etc.

Thus, while Scherübl teaches a confocal microscope capable of

detecting defects in semiconductor devices, the present invention can

identify the type of entity. Accordingly, the present claimed invention is

directed to a "method for optically detecting at least one entity chosen from

the group consisting of molecules, molecule complexes, polymers, polymeric

particles, particles built up from inorganic materials, vesicular structures,

cells, bacteria and virus." Scherübl, on the other hand, is directed to

detecting deviations between a first vertical profile and a second vertical

profile. Accordingly, Applicant submits that the present method of detecting

an entity and Scherübl's method of detecting defects are completely

different.

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Furthermore, the method of claim 24 comprises, among other things,

scanning an entity with a measuring volume using a device comprising a

first radiation source, generating an auxiliary focus by a second radiation

source, detecting a retroreflection from the auxiliary focus, and using the

retroreflection for measuring the position of the interface and the position of

the measuring volume. In contrast, Scherübl discloses a confocal

microscope having an illumination light of different wavelengths focused in

different planes of the object and a light of different wavelengths emitted by

the object. In Scherübl, height information of the object is transformed into

a spectral intensity distribution. Thus, Applicant submits that Scherübl

does not teach claimed all elements of claim 24.

Picard is also directed to an assembly that includes a spectrum light

source and focusing mechanism for focusing point sources on an object in

order to obtain three-dimensional imaging. Thus, Picard also is not directed

to maintaining a confocal measuring volume in a desired plane within an

object. Applicant submits that Picard does not make up for the deficiency in

Scherübl.

Accordingly, Applicant respectfully requests that the rejection be

withdrawn.

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CONCLUSION

All objections and rejections raised in the Office Action having been

addressed, it is respectfully submitted that the present application is in

condition for allowance and such allowance is respectfully solicited. Should

there be any outstanding matters that need to be resolved in the present

application, the Examiner is respectfully requested to contact Robert W.

Downs (Reg. No. 48,222), to conduct an interview in an effort to expedite

prosecution in connection with the present application.

Pursuant to 37 C.F.R. §§ 1.17 and 1.136(a), Applicant respectfully

petitions for a three (3) month extension of time for filing a reply in

connection with the present application, and the required fee of \$980.00 is

attached hereto.

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If necessary, the Commissioner is hereby authorized in this, concurrent, and future replies, to charge payment or credit any overpayment to Deposit Account No. 02-2448 for any additional fees required under 37 C.F.R. §§ 1.16 or 1. 17; particularly, extension of time fees.

Respectfully submitted,

BIRCH, STEWART, KOLASCH &, BIRCH, LLP

3v: ,

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Attachment(s):

Figure 6 Replacement Sheet English language translation of Provisional Appl. 60/113,478

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DRAWINGS

Attached hereto is one (1) sheet of a corrected formal drawing that complies with the provisions of 37 C.F.R. § 1.84. The corrected formal drawing incorporates the following drawing changes:

The drawings have been corrected to add a lens mover portion 85 to Fig. 6.

It is respectfully requested that the corrected formal drawing be approved and made a part of the record of the above-identified application.